



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Seishiro Fujii et al.

Art Unit: 1645

Serial No.: 10/664,795

Examiner: Unknown

Filed

: September 19, 2003

Title : METHODS AND COMPOSITIONS FOR PREVENTING SKIN DAMAGE

MAIL STOP AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed before the receipt of a first Office Action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 12/13/04

Ramon K. Tabtiang Reg. No. 55,658

Fish & Richardson P.C. 225 Franklin Street

Boston, MA 02110-2804 Telephone: (617) 542-5070 Facsimile: (617) 542-8906

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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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Sheet	1	of	1

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Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10287-077001	Application No. 10/664,795			
Information Disclosure Statement DEC 1 5 2004 by Applicant		Applicant Seishiro Fujii et al.				
(Use several s	heets if necessary)	Filing Date September 19, 2003	Group Art Unit 1645			
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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,753,263	May 19, 1998	Lishko et al.			
	AB	6,224,901	May 1, 2001	Li et al.			
	AC						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL							
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	AN							-
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	Other D	ocuments (include Author, Title, Date, and Place of Publication)
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EXAMINER: Initials citation considered. Draw line through citation if n next communication to applicant.	ot in conformance and not considered. Include copy of this form with